
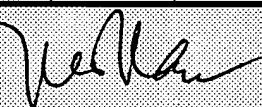



<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/665,920	MILLER, EDWARD E.	
	Examiner	Art Unit	
	Hiep Nguyen	2816	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
327		77		327	205	206			
INTERNATIONAL CLASSIFICATION									
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HIEP NGUYEN 07.24.05 (Assistant Examiner) (Date)				 TUAN T. LAM PRIMARY EXAMINER (Primary Examiner)				Total Claims Allowed: 1	
 Anne Smith 8/1/05 (Legal Instruments Examiner) (Date)				7/30/05 (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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